

## **MOSFET** – P-Channel, POWERTRENCH®

-30 V, -18 A, 20 m $\Omega$ 

## FDMC4435BZ, FDMC4435BZ-F127

#### **General Description**

This P-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

#### **Features**

- Max  $r_{DS(on)} = 20 \text{ m}\Omega$  at  $V_{GS} = -10 \text{ V}$ ,  $I_D = -8.5 \text{ A}$
- Max  $r_{DS(on)} = 37 \text{ m}\Omega$  at  $V_{GS} = -4.5 \text{ V}$ ,  $I_D = -6.3 \text{ A}$
- Extended V<sub>GSS</sub> Range (-25 V) for Battery Applications
- High Performance Trench Technology for Extremely Low r<sub>DS(on)</sub>
- High Power and Current Handling Capability
- HBM ESD Protection Level > 7 kV Typical\*
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

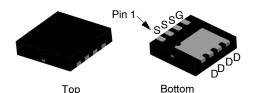
#### **Applications**

- High Side in DC DC Buck Converters
- Notebook Battery Power Management
- Load Switch in Notebook



WDFN8 3.3x3.3, 0.65P CASE 511DR

FDMC4435BZ



WDFN8 3.3x3.3, 0.65P CASE 511DQ

FDMC4435BZ-F127

#### **MARKING DIAGRAM**



FDMC 4435BZ ALYW

FDMC4435BZ

FDMC4435BZ-F127

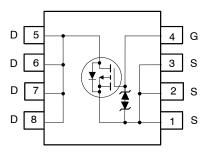
FDMC4435BZ = Specific Device Code

A = Assembly Location XY = 2-Digit Date Code

KK = 2-Digit Lot Run Traceability Code

L = Wafer Lot Number YW = Assembly Start Week

#### **PIN ASSIGNMENT**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 6 of this data sheet.

<sup>\*</sup>The diode connected between the gate and source servers only as protection against ESD. No gate overvoltage rating is implied.

#### MOSFET MAXIMUM RATINGS ( $T_A = 25^{\circ}C$ unless otherwise noted)

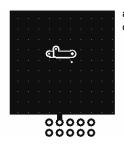
Symbol	Parameter			Rating	Unit
$V_{DS}$	Drain to Source Voltage			-30	V
V <sub>GS</sub>	Gate to Source Voltage			±25	V
I <sub>D</sub>	Drain Current	Continuous	T <sub>C</sub> = 25°C	-18	Α
		Continuous (Note 1a)	T <sub>A</sub> = 25°C	-8.5	
		Pulsed	•	-50	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 2	2)		32	mJ
$P_{D}$	Power Dissipation $T_C = 25^{\circ}C$		31	W	
	Power Dissipation (Note 1a)		T <sub>A</sub> = 25°C	2.3	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Tempe	rature Range	•	-55 to + 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Rating	Unit
Rejc	Thermal Resistance, Junction to Case	4	°C/W
RθJA	Thermal Resistance, Junction to Ambient (Note 1a)	53	

<sup>1.</sup>  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $53^{\circ}$ C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b.  $125^{\circ}\text{C/W}$  when mounted on a minimum pad of 2 oz copper

2. Starting  $T_J = 25^{\circ}C$ ; P-ch: L = 1 mH,  $I_{AS} = -8$  A,  $V_{DD} = -27$  V,  $V_{GS} = -10$  V.

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS		•		•	-
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = -250 \mu\text{A},  V_{GS} = 0 \text{V}$	-30			V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, referenced to 25°C		21		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -24 V, V <sub>GS</sub> = 0 V			-1	μΑ
		V <sub>DS</sub> = -24 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125°C			-100	1
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V			±10	μΑ
ON CHARAC	CTERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu\text{A}$	-1.0	-1.8	-3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, referenced to 25°C		-5		mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -8.5 A		14	20	mΩ
		V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -6.3 A		21	37	1
		V <sub>GS</sub> = -10 V, I <sub>D</sub> = -8.5 A, T <sub>J</sub> = 125°C		20	29	1
9FS	Forward Transconductance	$V_{DD} = -5 \text{ V}, I_D = -8.5 \text{ A}$		25		S
DYNAMIC C	HARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1535	2040	pF
C <sub>oss</sub>	Output Capacitance	1		310	410	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1		280	420	pF
Rg	Gate Resistance	f = 1 MHz		4		Ω
SWITCHING	CHARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -15 \text{ V}, I_D = -8.5 \text{ A}, V_{GS} = -10 \text{ V},$		10	20	ns
t <sub>r</sub>	Rise Time	$R_{GEN} = 6 \Omega$		9	18	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1		35	56	ns
t <sub>f</sub>	Fall Time	1		19	34	ns
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } -10 \text{ V},$ $V_{DD} = -15 \text{ V}, I_D = -8.5 \text{ A}$		38	53	nC
		V <sub>GS</sub> = 0 V to -4.5 V, V <sub>DD</sub> = -15 V, I <sub>D</sub> = -8.5 A		20	28	nC
Q <sub>gs</sub>	Gate to Source Charge	$V_{DD} = -15 \text{ V}, I_D = -8.5 \text{ A}$		4.3		nC
$Q_{gd}$	Gate to Drain "Miller" Charge			11		nC
DRAIN-SOU	IRCE DIODE CHARACTERISTICS					
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -8.5 A (Note 3)		0.86	1.5	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = -1.9 A (Note 3)		0.74	1.2	1
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = -8.5 A, di/dt = 100 A/μs		26	40	ns
Q <sub>rr</sub>	Reverse Recovery Charge	1		12	20	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.

#### TYPICAL CHARACTERISTICS (T, = 25°C unless otherwise noted)

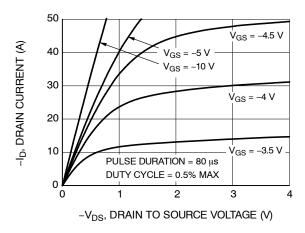


Figure 1. On Region Characteristics

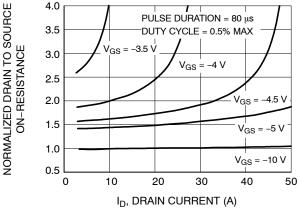


Figure 2. Normalized On–Resistance vs.
Drain Current and Gate Voltage

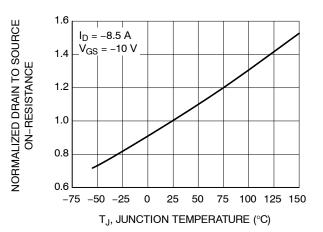


Figure 3. Normalized On Resistance vs. Junction Temperature

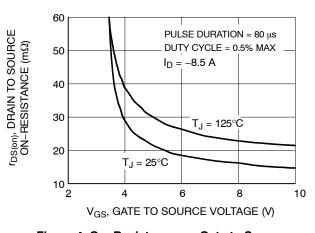


Figure 4. On-Resistance vs. Gate to Source Voltage

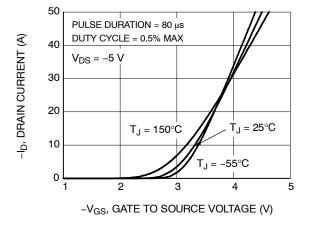


Figure 5. Transfer Characteristics

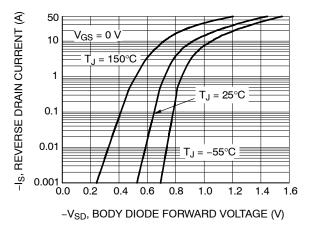


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

#### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

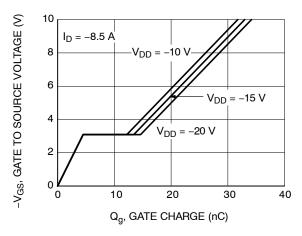


Figure 7. Gate Charge Characteristics

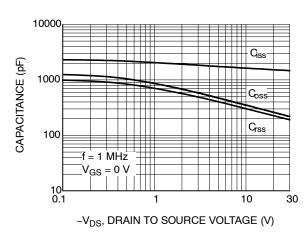


Figure 8. Capacitance vs. Drain to Source Voltage

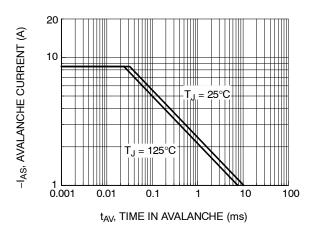


Figure 9. Unclamped Inductive Switching Capability

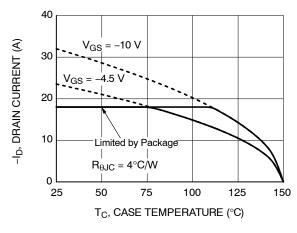


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

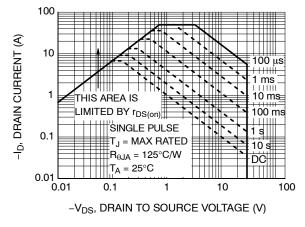


Figure 11. Forward Bias Safe Operating Area

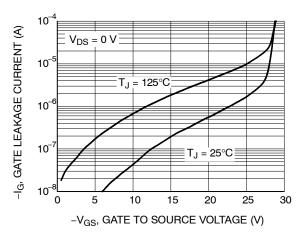


Figure 12. I<sub>GSS</sub> vs. V<sub>GSS</sub>

#### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

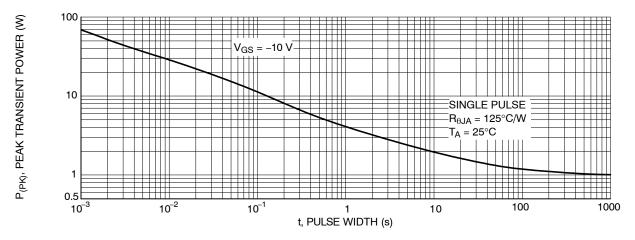


Figure 13. Single Pulse Maximum Power Dissipation

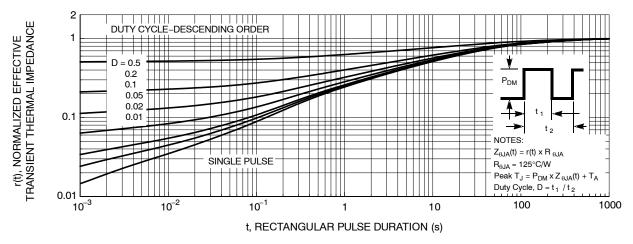


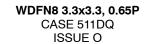
Figure 14. Junction-to-Ambient Transient Thermal Response Curve

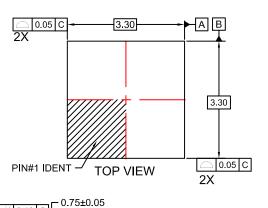
#### **ORDERING INFORMATION**

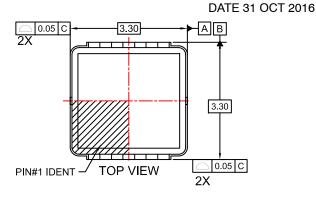
Device	Device Marking	Package Type	Shipping <sup>†</sup>
FDMC4435BZ	FDMC4435BZ	WDFN8 3.3x3.3, 0.65P, case 511DR (Pb-Free)	3000 / Tape & Reel
FDMC4435BZ-F127	FDMC4435BZ	WDFN8 3.3x3.3, 0.65P, case 511DQ (Pb-Free)	3000 / Tape & Reel
FDMC4435BZ-F127-L701	FDMC4435BZ	WDFN8 3.3x3.3, 0.65P, case 511DQ (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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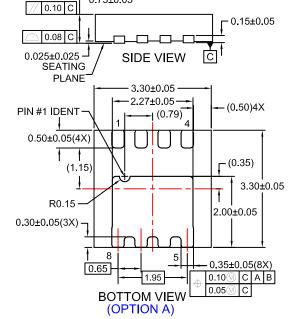


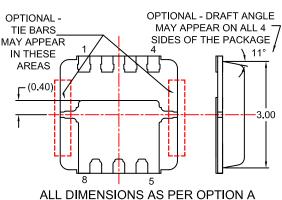


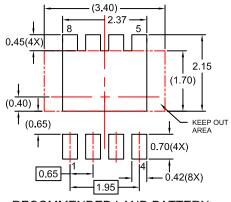


3.20

SIDE VIEW







UNLESS SPECIFIED

BOTTOM VIEW

(OPTION B)

RECOMMENDED LAND PATTERN

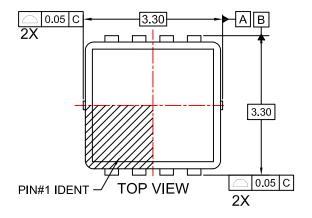
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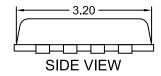
DESCRIPTION: WDFN8 3.3X3.3, 0.65P PAGE 1 OF 2

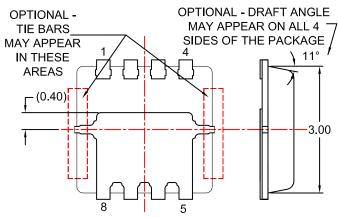
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#### WDFN8 3.3x3.3, 0.65P CASE 511DQ ISSUE O

**DATE 31 OCT 2016** 







# ALL DIMENSIONS AS PER OPTION A UNLESS SPECIFIED BOTTOM VIEW (OPTION C)

#### NOTES:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-240.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN
- E. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. BURRS OR MOLD FLASH SHALL NOT EXCEED 0.10MM.

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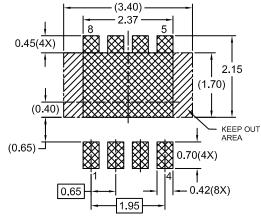


**DATE 02 FEB 2022** 

#### NOTES:

- A. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- B. SEATING PLANE IS DEFINED BY TERMINAL TIPS ONLY
- C. BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS. MOLD FLASH PROTRUSION OR GATE BURR DOES NOT EXCEED 0.150MM.

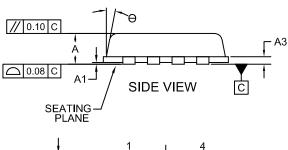
DIM	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
A1	0.00	ı	0.05	
А3	0.15	0.20	0.25	
b	0.27	0.32	0.37	
D	3.20	3.30	3.40	
D1	3.10	3.20	3.30	
D3	2.17	2.27	2.37	
Е	3.20	3.30	3.40	
E1	2.90	3.00	3.10	
E2	1.95	2.05	2.15	
E3	0.15	0.20	0.25	
E4	0.30	0.40	0.50	
E5	0.40 REF			
е	0.65 BSC			
L	0.30	0.40	0.50	
θ	0°	-	12°	

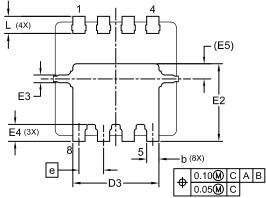


#### RECOMMENDED LAND PATTERN

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

### ○ 0.10 C 2X В E1 PIN1 □ 0.10 C IDENT TOP VIEW





**BOTTOM VIEW** 

#### **GENERIC MARKING DIAGRAM\***

XXXX AYWW= XXXX = Specific Device Code = Assembly Location = Year = Work Week WW

= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

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